Se	arch	Note:	S	

	Application/Control No.	Applicant(s)/Patent under Reexamination	
Ì	10/611,923	YONENO ET AL	
ľ	Examiner	Art Unit	
	Prabodh M. Dharia	2629	

SEARCHED			
Class	Subclass	Date	Examiner
345	156-159, 864,784, 173,-179 169	10/10/2006	PD
345	184		
379	93,37		
235	462.45		
382	115		
709	229		
455	556 ·		
715	864		
463	047		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
345	156-159	10/10/2006	PD
345	173-179		
345	864,169		
rest as listed above Interfrence search per (US-PGPUB)			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East text search (US-PGPUB; USPAT; JPO; EPO: DEREWENT; IBM_TDB)	10/10/2006	PD	
Assisted by Vijay Shankar	7/23/2006	PD	
Henry Tran			
Xiao M Wu			
Amare Mengistu			
Kent Chang			